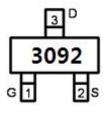
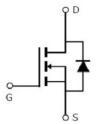


## **Main Product Characteristics:**

V <sub>DSS</sub>	30V
R <sub>DS</sub> (on)	92mohm(typ.)
l <sub>D</sub>	1.4A ①







SOT23

Marking and pin
Assignment

Schematic diagram

### **Features and Benefits:**

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



## **Description:**

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

## **Absolute max Rating:**

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ TC = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	1.4①	
I <sub>D</sub> @ TC = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	1①	Α
I <sub>DM</sub>	Pulsed Drain Current ②	8.4	
P <sub>D</sub> @TC = 25°C	Power Dissipation	0.62	W
V <sub>DS</sub>	Drain-Source Voltage	30	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 150	°C

### **Thermal Resistance**

Symbol	Characterizes	Тур.	Max.	Units
R <sub>θJA</sub>	Junction-to-ambient (t ≤ 10s) ③	_	200	°C/W





# **Electrical Characterizes** @T<sub>A</sub>=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source breakdown voltage	30	_	_	V	$V_{GS} = 0V$ , $I_D = 250\mu A$
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	_	92	120	mΩ	V <sub>GS</sub> =10V,I <sub>D</sub> = 1.4A
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	_	120	160	mΩ	V <sub>GS</sub> =4.5V,I <sub>D</sub> =1.2A
$V_{GS(th)}$	Gate threshold voltage	1	_	3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
	Drain to Source leakage current	_	_	1		$V_{DS} = 30V, V_{GS} = 0V$
I <sub>DSS</sub>	Drain-to-Source leakage current	_	_	50	μA	T <sub>J</sub> = 125°C
L	Cata to Source forward lookage		_	100	20	V <sub>GS</sub> =20V
I <sub>GSS</sub> Gate-to-	Gate-to-Source forward leakage		_	-100	nA	V <sub>GS</sub> = -20V
Qg	Total gate charge		1.3	_		I <sub>D</sub> = 1.4A,
$Q_{gs}$	Gate-to-Source charge	_	0.5	_	nC	V <sub>DS</sub> =15V,
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	_	0.5	_		V <sub>GS</sub> = 4.5V
t <sub>d(on)</sub>	Turn-on delay time	_	3	_		
tr	Rise time	_	5	_		V <sub>GS</sub> =10V, V <sub>DS</sub> =15V,
t <sub>d(off)</sub>	Turn-Off delay time		20	_	ns	$R_{GEN}$ =6 $\Omega$ , $R_{L}$ =15 $\Omega$ ,
<b>t</b> f	Fall time	_	2	_		
C <sub>iss</sub>	Input capacitance	_	135	_		V <sub>GS</sub> = 0V,
Coss	Output capacitance	_	30	_	pF	V <sub>DS</sub> =15V,
C <sub>rss</sub>	Reverse transfer capacitance	_	20	_		f = 1MHz

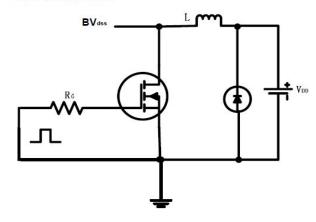
# **Source-Drain Ratings and Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current		_	1.4 ①	Α	MOSFET symbol
	(Body Diode)	_				showing the
I <sub>SM</sub>	Pulsed Source Current	_	_	8.4	Α	integral reverse
	(Body Diode)					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	_	0.72	1.2	V	I <sub>S</sub> =1A, V <sub>GS</sub> =0V

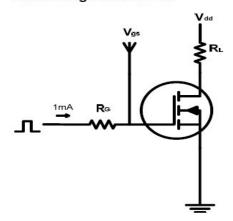


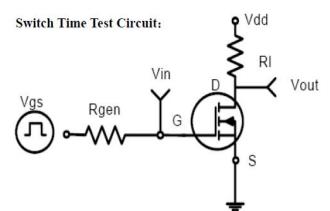
### **Test circuits and Waveforms**

### EAS test circuits:

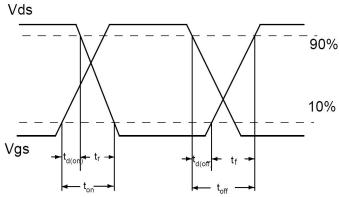


#### Gate charge test circuit:





#### **Switch Waveforms:**

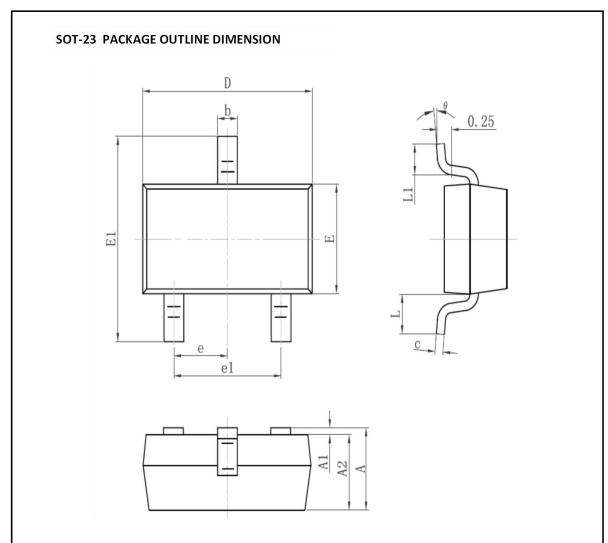


### Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max junction temperature.
- (4) These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C.



# **Mechanical Data:**



Symbol	Dimension I	n Millimeters	Dimension In Inches		
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
<b>A</b> 2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
C	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
Е	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.95	0.95TYP		7TYP	
e1	1.800	2.000	0.071	0.079	
L	0.55REF		0.02	2REF	
L1	0.300	0.500	0.012	0.020	
θ	00	8°	00	8 <sup>0</sup>	





# **Ordering and Marking Information**

**Device Marking: 3092** 

Package (Available) SOT-23 Operating Temperature Range C:-55 to 150 °C

## **Devices per Unit**

Package	Units/	Tubes/Inner	Units/Inner	Inner	Units/Carton
Type	Tube	Box	Box	Boxes/Carton	Box
				Box	
SOT23	3000		30000		120000

## **Reliability Test Program**

<b>Test Item</b>	Conditions	Duration	Sample Size
High	Tj= 150℃ @ 80% of	168 hours	3 lots x 77 devices
Temperature	Max V <sub>DSS</sub> /V <sub>CES</sub> /V <sub>R</sub>	500 hours	
Reverse		1000 hours	
Bias(HTRB)			
High	Tj=150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V <sub>GSS</sub>	500 hours	
Gate		1000 hours	
Bias(HTGB)			





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